





Report No.: 18270BC00291401

Lithium Battery UN38.3 Test Report

Client Name

: SONEIL INTERNATIONAL LIMITED

Address

46 West Drive, Brampton, Ontario, CANADA L6T 3T6

Product Name

LiFePO₄ Battery Pack

Date

Dec. 24, 2020

Shenzhen Anbotek Compliance Laboratory Limited

Code: AB-BAT-71-b

Hotline 400-003-0500 www.anbotek.com



Report No.: 18270BC00291401

Page 2 of 13

1. SAMPLE DESCRIPTION:

Sample Name:			ePO ₄ Battery Pack	Samp	le Model:	LFP19256SI	-Glacker		
Manufacturer:	2/2	SOI	NEIL INTERNATIONA	L LIMITED	William Polek	anbotek.	Wesperson		
Address of manufa	cturer:		A5/5F, Long Sheng Business Building, No. 402 He Ping Road, Long Hua District, Shenzhen, 518109, P.R. China, Postcode: 518109						
Factory:	" upotek	SOI	NEIL INTERNATIONA	L LIMITED	P. D.	Pope De	loo _{fel} e		
Address of factory:	Anhot		5F, Long Sheng Busin rict, Shenzhen, 51810				Long Hua		
Nominal Voltage:	Iominal Voltage: 19.2V		Rated Capacity:	5.6Ah 107.52Wh	T ⁱ Antooral	rademark:	/ Antone		
Charge Current:	2A	Pul	Maximum Continuous Charge Current:	6A _{Arthoored}		nd Charge current:	0.2A		
Cut-off Voltage:	12V	otel ^k	Maximum Discharge Current:	20A	. 32.	imited Charge oltage:	21.9V		
Cells Number:	12	unbote	Cell Model:	IFR26650-3	57/2	ell Rated apacity:	3Ah		
Date of Sample Rec	ceived:	Dec	:. 04, 2020	Anbore	V.				
Date of Test:	AU posen	Dec	. 04, 2020 to Dec. 16,	2020	Ville	Lotek Ant	ote _k		

Tested by: Fason har

Checked by: Dela

vely Yang

Approved by:

Davis Yorg



Report No.: 18270BC00291401 Page 3 of 13

2. REFERENCE METHOD

United Nations Recommendations On The Transport Of Dangerous Goods, Manual Of Tests And Criteria (ST/SG/AC.10/11/Rev.6/Amend.1)

3. EQUIPMENT LIST

Name of equipment /Model	Serial No.	Due Date
Low Pressure Test Machine BE-DY-125	SE-132	2021-03-10
High Fast Temperature&Humidity Chamber ZJ-KSWB1506	SE-1488	2021-08-09
Vibration Machine EV103V	SE-439	2021-09-27
Shock Machine HSKT-10	SE-440	2021-04-01
Thermostat Short-circuit Testing Machine BE-1000W	SE-133	2021-03-10
Impact Testing Machine BE-5060	SE-136	2021-07-12
Battery Charge And Discharge System CT-4002-80V40A-NA TRUE BMS multimator	SE-1507	2021-08-09
TRUE RMS multimeter MS8040	SE-511	2021-03-10
Electronic scale CHS-D	SE-1483	2021-07-12
Temperature rise recorder 34970A	SE-004	2021-03-15

Hotline 400-003-0500

Code: AB-BAT-71-b

www.anbotek.com



Report No.: 18270BC00291401 Page 4 of 13

4. ENVIRONMENTAL CONDITIONS OF THE TEST

Temperature: (20±5) °C R.H.: (40~70) %RH

5. TEST ITEM AND CONCLUSION

ITEM ex anhotek Ant	SAMPLE NUMBER	STANDARD	CONCLUSION
Altitude simulation	B1~B4, B5~B8	Anborer Anb	PASS
Thermal test	Anbore And borek	Anbotek Anbo	PASS
Vibration	Anbore And hot	ek Anbotek Anbo	PASS
Shock	Anbore, And	ST/SG/AC.10/11/Rev.	PASS
External short circuit	otsk Wupoter Wu	6/Amend.1	PASS
Impact	C21~C25, C26~C30	Anbotek Anbotek	PASS
Overcharge	B9~B12, B13~B16	And otek anbotek	PASS
Forced discharge	C1~C10, C11~C20	Anbo stek Anbore	PASS

Notes:

B1~B4: Batteries at first cycle in fully charged states;

B5~B8: Batteries after 25 cycles ending in fully charged states;

B9~B12: Batteries at first cycle in fully charged states;

B13~B16: Batteries after 25 cycles ending in fully charged states.

C1~C10: Cells at first cycle in fully charged states;

C11~C20: Cells after 25 cycles ending in fully discharged states. C21~C25: Cells at first cycle at 50% of the design rated capacity; C26~C30: Cells at 25 cycle at 50% of the design rated capacity;



Report No.: 18270BC00291401 Page 5 of 13

TEST METHOD

Tests T.1 to T.5 shall be conducted in sequence on the same cell or battery. Tests T.6 and T.8 shall be conducted using not otherwise tested cells or batteries. Test T.7 may be conducted using undamaged batteries previously used in tests T.1 to T.5 for purposes of testing on cycled batteries. In order to quantify the mass loss, the following procedure is provided:

Mass loss(%) = $(M1-M2) / M1 \times 100$

Where M1 is the mass before the test and M2 is the mass after the test. When mass loss does not exceed the values in Table blow, it shall be considered as "no mass loss".

Mass M of cell or battery	Mass loss limit
M<1(g)	0.5%
1g≤M≤75(g)	0.2%
M>75(g)	0.1%

T.1 Altitude simulation

Test cells and batteries shall be stored at a pressure of 11.6 kPa or less for at least six hours at ambient temperature (20 ± 5 °C).

Cells and batteries meet this requirement if there is no leakage, no venting, no disassembly, no rupture and no fire and if the open circuit voltage of each test cell or battery after testing is not less than 90% of its voltage immediately prior to this procedure. The requirement relating to voltage is not applicable to test cells and batteries at fully discharged states.

T.2 Thermal test

Test cells and batteries are to be stored for at least six hours at a test temperature equal to $72 \pm 2^{\circ}$ C, followed by storage for at least six hours at a test temperature equal to $-40 \pm 2^{\circ}$ C. The maximum time interval between test temperature extremes is 30 minutes. This procedure is to be repeated until 10 total cycles are complete, after which all test cells and batteries are to be stored for 24 hours at ambie nt temperature ($20 \pm 5^{\circ}$ C). For large cells and batteries the duration of exposure to the test temperature extremes should be at least 12 hours.

Cells and batteries meet this requirement if there is no leakage, no venting, no disassembly, no rupture and no fire and if the open circuit voltage of each test cell or battery after testing is not less than 90% of its voltage immediately prior to this procedure. The requirement relating to voltage is not applicable to test cells and batteries at fully discharged states.

T.3 Vibration

Cells and batteries are firmly secured to the platform of the vibration machine without distorting the cells in such a manner as to faithfully transmit the vibration. The vibration shall be a sinusoidal waveform with a logarithmic sweep between 7 Hz and 200 Hz and back to 7 Hz traversed in 15 minutes. This cycle shall be repeated 12 times for a total of 3 hours for each of three mutually perpendicular mounting positions of the cell. One of the directions of vibration must be perpendicular to the terminal face. The logarithmic frequency sweep shall differ for cells and batteries with a gross mass of not more than 12 kg (cells and small batteries), and for batteries with a gross mass of more than 12 kg (large batteries).

For cells and small batteries: from 7 Hz a peak acceleration of 1 gn is maintained until 18 Hz is reached. The amplitude is then maintained at 0.8 mm (1.6 mm total excursion) and the frequency increased until a peak acceleration of 8 gn occurs (approximately 50 Hz). A peak acceleration of 8 gn is then maintained until the frequency is increased to 200 Hz.

For large batteries: from 7 Hz to a peak acceleration of 1 gn is maintained until 18 Hz is reached. The amplitude is then maintained at 0.8 mm (1.6 mm total excursion) and the frequency increased until a





Report No.: 18270BC00291401 Page 6 of 13

peak acceleration of 2 gn occurs (approximately 25 Hz). A peak acceleration of 2 gn is then maintained until the frequency is increased to 200 Hz.

Cells and batteries meet this requirement if there is no leakage, no venting, no disassembly, no rupture and no fire during the test and after the test and if the open circuit voltage of each test cell or battery directly after testing in its third perpendicular mounting position is not less than 90% of its voltage immediately prior to this procedure. The requirement relating to voltage is not applicable to test cells and batteries at fully discharged states.

T.4 Shock

Test cells and batteries shall be secured to the testing machine by means of a rigid mount which will support all mounting surfaces of each test battery.

Each cell shall be subjected to a half-sine shock of peak acceleration of 150 gn and pulse duration of 6 milliseconds. Alternatively, large cells may be subjected to a half-sine shock of peak acceleration of 50 gn and pulse duration of 11 milliseconds.

Each battery shall be subjected to a half-sine shock of peak acceleration depending on the mass of the battery. The pulse duration shall be 6 milliseconds for small batteries and 11 milliseconds for large batteries. The formulas below are provided to calculate the appropriate minimum peak accelerations.

Battery	Minimum peak acceleration	Pulse duration
Small batteries	150 g _n or result of formula $Acceleration(gn) = \sqrt{\frac{100850}{\text{mass}*}}$	Anborek Anbore
Anborek Anborek Ar	whichever is smaller 50 gn or result of formula	otek Anbotek
Large batteries	Acceleration(gn)= $\sqrt{\left(\frac{30000}{\text{mass}*}\right)}$ whichever is smaller	Anborek 11 ms borek

^{*} Mass is expressed in kilograms.

Each cell or battery shall be subjected to three shocks in the positive direction and to three shocks in the negative direction in each of three mutually perpendicular mounting positions of the cell or battery for a total of 18 shocks.

Cells and batteries meet this requirement if there is no leakage, no venting, no disassembly, no rupture and no fire and if the open circuit voltage of each test cell or battery after testing is not less than 90% of its voltage immediately prior to this procedure. The requirement relating to voltage is not applicable to test cells and batteries at fully discharged states.

T.5 External short circuit

The cell or battery to be tested shall be shall be heated for a period of time necessary to reach a homogeneous stabilized temperature of $57\pm4^{\circ}\text{C}$, measured on the external case. This period of time depends on the size and design of the cell or battery and should be assessed and documented. If this assessment is not feasible, the exposure time shall be at least 6 hours for small cells and small batteries, and 12 hours for large cells and large batteries. Then the cell or battery at $57\pm4^{\circ}\text{C}$ shall be subjected to one short circuit condition with a total external resistance of less than 0.1 ohm. This short circuit condition is continued for at least one hour after the cell or battery external case temperature has returned to $57\pm4^{\circ}\text{C}$, or in the case of the large batteries, has decreased by half of the maximum temperature increase observed during the test and remains below that value. The short circuit and cooling down phases shall be conducted at least at ambient temperature. Cells and batteries meet this requirement if their external temperature does not exceed 170°C and there is no disassembly, no rupture and no fire during the test and within six hours after the test.

Shenzhen Anbotek Compliance Laboratory Limited

Hotline 400-003-0500 www.anbotek.com



Report No.: 18270BC00291401 Page 7 of 13

T.6 Impact / Crush

Impact (applicable to cylindrical cells greater than 18 mm in diameter)

The sample cell or component cell is to be placed on a flat smooth surface. A 15.8 mm \pm 0.1mm diameter, at least 6 cm long, or the longest dimension of the cell, whichever is greater, Type 316 stainless steel bar is to be placed across the centre of the sample. A 9.1 kg \pm 0.1 kg mass is to be dropped from a height of 61 \pm 2.5 cm at the intersection of the bar and sample in a controlled manner using a near frictionless, vertical sliding track or channel with minimal drag on the falling mass. The vertical track or channel used to guide the falling mass shall be oriented 90 degrees from the horizontal supporting surface.

The test sample is to be impacted with its longitudinal axis parallel to the flat surface and perpendicular to the longitudinal axis of the 15.8 mm \pm 0.1mm diameter curved surface lying across the centre of the test sample. Each sample is to be subjected to only a single impact.

Crush (applicable to prismatic, pouch, coin/button cells and cylindrical cells not more than 18 mm in diameter)

A cell or component cell is to be crushed between two flat surfaces. The crushing is to be gradual with a speed of approximately 1.5 cm/s at the first point of contact. The crushing is to be continued until the first of the three options below is reached.

- (a) The applied force reaches 13 kN ± 0.78 kN;
- (b) The voltage of the cell drops by at least 100 mV; or
- (c) The cell is deformed by 50% or more of its original thickness.

Once the maximum pressure has been obtained, the voltage drops by 100 mV or more, or the cell is deformed by at least 50% of its original thickness, the pressure shall be released.

A prismatic or pouch cell shall be crushed by applying the force to the widest side. A button/coin cell shall be crushed by applying the force on its flat surfaces. For cylindrical cells, the crush force shall be applied perpendicular to the longitudinal axis.

Each test cell or component cell is to be subjected to one crush only. The test sample shall be observed for a further 6 h. The test shall be conducted using test cells or component cells that have not previously been subjected to other tests.

Cells and component cells meet this requirement if their external temperature does not exceed 170°C and there is no disassembly and no fire during the test and within six hours after this test.

T.7 Overcharge

The charge current shall be twice the manufacturer's recommended maximum continuous charge current. The minimum voltage of the test shall be as follows:

- (a) When the manufacturer's recommended charge voltage is not more than 18V, the minimum voltage of the test shall be the lesser of two times the maximum charge voltage of the battery or 22V.
- (b) When the manufacturer's recommended charge voltage is more than 18V, the minimum voltage of the test shall be 1.2 times the maximum charge voltage.

Tests are to be conducted at ambient temperature; the duration of the test shall be 24 hours. Rechargeable batteries meet this requirement if there is no disassembly and no fire during the test and within seven days after the test.

T.8 Forced discharge

Each cell shall be forced discharged at ambient temperature by connecting it in series with a 12V D.C. power supply at an initial current equal to the maximum discharge current specified by the manufacturer. The specified discharge current is to be obtained by connecting a resistive load of the appropriate size and rating in series with the test cell. Each cell shall be forced discharged for a time interval (in hours) equal to its rated capacity divided by the initial test current (in ampere).

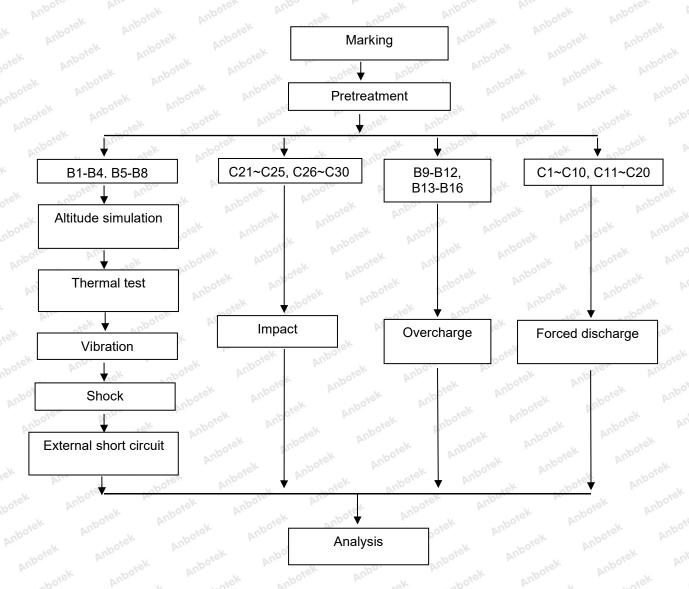
Primary or rechargeable cells meet this requirement if there is no disassembly and no fire during the test and within seven days after the test.





Report No.: 18270BC00291401 Page 8 of 13

7. TEST PROCEDURE





Report No.: 18270BC00291401 Page 9 of 13

8. DATA

T.1 Altitude simulation

No.	No. Pre-test		Pre-test After test		Mass	Voltage	Whether leakage,
Anbotek	Mass (g)	Voltage (V)	Mass (g)	Voltage (V)	loss (%) (%)		venting, disassembly, rupture, fire (Y/N)
B1,501®	1178.62	20.019	1178.62	20.019	0.00	0.00	AndN
B2	1178.63	20.012	1178.63	20.012	0.00	0.00	rek Notes
B3 000	1178.49	20.021	1178.42	20.019	0.01	0.01	N *ek
B4	1178.18	20.015	1178.18	20.015	0.00	0.00	hotek Nanbo
90 B5 ₽	1176.54	20.017	1176.54	20.017	0.00	0.00	In N Potek
B6	1178.79	20.016	1178.79	20.016	0.00	0.00	Anbore N Ans
Anb B7	1178.46	20.013	1178.40	20.013	0.01	0.00	oteVN Anbore
B8	1178.47	20.018	1178.47	20.016	0.00	0.01	Anba N

T.2 Thermal test

No.	Pre-test		Afte	test Anbou	Mass	Voltage	Whether leakage,
kupotek k	Mass (g)	Voltage (V)	Mass (g)	Voltage (V)	loss (%)	Loss (%)	venting, disassembly, rupture, fire (Y/N)
B1	1178.62	20.019	1178.31	19.949	0.03	0.35	Ne so
B2	1178.63	20.012	1178.39	19.957	0.02	0.27	anboN Am
В3	1178.42	20.019	1178.16	19.946	0.02	0.36	Notek D
B4	1178.18	20.015	1177.98	19.943	0.02	0.36	Ker AN
B5	1176.54	20.017	1176.32	19.957	0.02	0.30	tek Nabotes
36 N	1178.79	20.016	1178.45	19.943	0.03	0.36	ipo N sek
B7	1178.40	20.013	1178.16	19.941	0.02	0.36	botek N Anbo
B8	1178.47	20.016	1178.09	19.935	0.03	0.40	An shorek

T.3 Vibration

4	No. nbo	Pre-test		After test		Mass	Voltage	Whether leakage,
olek		Mass (g)	Voltage (V)	Mass (g)	Voltage (V)	loss (%)	Loss (%)	venting, disassembly, rupture, fire (Y/N)
1/100	B1	1178.31	19.949	1178.31	19.949	0.00	0.00	otek N anbore
	B2	1178.39	19.957	1178.26	19.957	0.01	0.00	Anbo N
Di.	B3	1178.16	19.946	1178.16	19.944	0.00	0.01	sbot N Anbo
	B4	1177.98	19.943	1177.98	19.943	0.00	0.00	N _e k
	B5	1176.32	19.957	1176.16	19.957	0.01	0.00	sk augh, by
	B6	1178.45	19.943	1178.45	19.943	0.00	0.00	Notek
,eK	B7	1178.16	19.941	1178.16	19.941	0.00	0.00 ·s	or N
	B8	1178.09	19.935	1178.09	19.933	0.00	0.01	Jek Nabote





Report No.: 18270BC00291401 Page 10 of 13

T.4 Shock

Peak acceleration: 150 gn, Pulse duration: 6 ms

No.	Pre-test		Pre-test After test		Mass Voltage		Whether leakage,	
Anbotek Anbotek	Mass (g)	Voltage (V)	Mass (g)	Voltage (V)	loss (%)	Loss (%)	venting, disassembly, rupture, fire (Y/N)	
B1	1178.31	19.949	1178.31	19.949	0.00	0.00	N N	
B2	1178.26	19.957	1178.15	19.957	0.01	0.00	otek No	
В3	1178.16	19.944	1178.16	19.944	0.00	0.00	N botek	
NeVB4	1177.98	19.943	1177.98	19.941	0.00	0.01	NATTO NATTO	
B5	1176.16	19.957	1176.16	19.957	0.00	0.00	Total N Anbor	
B6	1178.45	19.943	1178.45	19.943	0.00	0.00	And LN Lote	
B7.	1178.16	19.941	1178.09	19.941	0.01	0.00	nbote N And	
B8	1178.09	19.933	1178.09	19.929	0.00	0.02	N/K and	

T.5 External short circuit

No.	Peak temperature (°C)	Whether disassembly, rupture, fire (Y/N)					
B1/b0	57.4	And K Lotek N Anbore Air					
B2 notek	57.6 tek	And N hotek Anbo.					
nbores B3 And	57.8 And	And And And And					
otek B4 Anbore	58.1	And K Mek Anboy An					
B5	58.2	tek anbore Ann ok borek					
B6	58.1 MIN	Moore And					
B7	57.3	botek Anbore N solek Anbore					
B8	57.5	tek above NAnt Ak bovek					

T.6 Impact

Anbor No.	Peak temperature (°C)	Whether disassembly, fire (Y/N)				
C21 Mark	26.4	And A Notek Anboy				
C22	26.1	otek potek				
C23	26.7	Joe Nanbore Am				
C24	26.1	abotek Anbo N Notek Anbort				
C25	26.3	All sek abote N Ante K sorek				
C26 botes	27.1 arek	Aupo, W. FekN Spore, Aug				
Anbo C27 Lek	26.5	notek Anbo N A sek anbo				
Lotek C28 Anbox	26.7	And K BONK Andor				
C29	26.8	ek anbore And N ok borek Ar				
C30	26.9	Note West				





Report No.: 18270BC00291401 Page 11 of 13

T.7 Overcharge

*ek	No.	er Ar	/v	Whe	ether disassem	nbly, fire (Y/N)	abotell	Aup
100.	B9	rek	"Upoter V.	Up	hotel N	Anbo.	rek	Vupose.
potek	B10	00	n'ek	Anbore	Ann	botek	Anbo	- O.K.
VII.	6 B11	botek	AUPO	otek	N Loon	Mr.	abotek	Aupo
Aupor	B12	Mr. rek	abotes	AUG	, N	Aupo,	by.	ik al
\natheresis	B13	Aupo.	p. stek	upore	PUR N	ok hotek	- Aupo.	p.
Vun	B14	100%	Sk Aupo		yek Wo	VIII	de Ye.	Otok
SK 0	B15	bu.	ek abo	ier Vup.	, N.	otek Anbo	Die.	*ek
__	B16	an'	DO. D.	ek	nbotes N.n		hotek 1	YUpo,

T.8 Forced discharge

~~			1-01 PI
be.	No.	aboles	Whether disassembly, fire (Y/N)
6	inbo C1	by.	ek Aupoles Aug ok Miek Aupol Miek
N.	C2	Aupo	otek nobote Ann Anbote Anbotek Anbotek
	C3	K 25	oter And k sotek Moore An aboter
otek	C4	br.	tek upoter. Aug K N Potek Augo, W. tek
, al	C5	otek	Anbor N And Ak Shotek Anbor
Nporc	C6	-ak	abotek Anbo Mark N Anbort All tok abot
100	otek C7	Npo,	An rek upotes Aur N notek Aupon An
VUD	C8	potek	Anbo, Andrew Anborn And And Hotek And
	oboto C9	Ann	k potek Ando Nek mbore And
	C10	Anbore	Ann botek Ann Ann Anton
36	Pur C11	, (orek Anbor Arrak Nooree Anbor k horek
Yer	C12	AUG	ok hotek Anbo. N stek anbote. And
0	C13	rek o	hoose And ak shorter NAhoo hatek anbose
poter	C14	V	Lotek Anbort Am sek N aborek Anb
bree	C15	abořek	And tek abover Ando N An tek abover And
Aupo	C16	rek	anbote And ak boteN Anbot At otek and
	50°C17	Aupo	notek Anbore An Nak aborek Anbo
100	C18	aboter	
/4-	C19	Dr.	ek upoter Ann K Notek Aupon William
Yan	C20	Anbe	Andrew Andrew Andrew Andrew

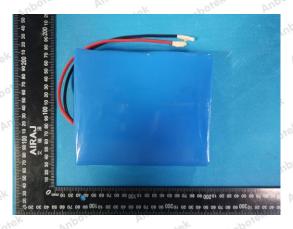


Report No.: 18270BC00291401

Page 12 of 13

9. PHOTOS OF THE SAMPLE





19.2V 5600mAH-107.52Wh Model No.: LFP19256SFG

Cell





Shenzhen Anbotek Compliance Laboratory Limited

Hotline 400-003-0500

Code: AB-BAT-71



Report No.: 18270BC00291401 Page 13 of 13

DECLARATION

- United Nations Recommendations On The Transport Of Dangerous Goods, Manual Of Tests And Criteria(ST/SG/AC.10/11/Rev.6/Amend.1).
- Test place Lab: Shenzhen Anbotek Compliance Laboratory Limited
 Address: East of 4/F., Building A, Hourui No.3 Industrial Zone, Xixiang Street,
 Bao'an District, Shenzhen, Guangdong, China
- 3. This report shall not be revised and deleted.
- 4. The test results presented in this report are only relevant to the test sample.
- 5. This report shall not be published as advertisement without the approval of Shenzhen Anbotek Compliance Laboratory Limited.
- This report shall not be copied partly without the written approval of Shenzhen Anbotek Compliance Laboratory Limited.

-- End of report --

